

**Search Notes**

Application/Control No.

10/784,594

Examiner

Yonel Beaulieu

Applicant(s)/Patent under  
Reexamination

OCKERSE ET AL.

Art Unit

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	200	7/12/2006	YB
	224		
702	92-93		
73	1.76		
434	186		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST (Bwd/Fwd)	7/12/2006	YB